Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | HALLER ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-----------------|----------------|
| | Α | US-5,577,901 | 11-1996 | Yoon, Deokyoung | 137/856 |
| | В | US-5,676,533 | 10-1997 | Park et al. | 137/857 |
| | С | US-6,012,489 | 01-2000 | Rene et al. | 137/856 |
| | D | US-6,314,990 | 11-2001 | Brabek et al. | 137/856 |
| | E | US- | | | |
| | F | US- | | | · |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|----------------|----------------|
| | N | JP 03255280 A | 11-1991 | Japan | TAKANO et al. | F16K 15/16 |
| | 0 | JP 10231783 A | 09-1998 | Japan | TARUYA et al. | F04B 27/08 |
| | Р | JP 2000329083 A | 11-2000 | Japan | SHIMADA et al. | F04C 29/00 |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | ٢ | | · | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | · |
| | > | |
| | W | |
| | X | |

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.